

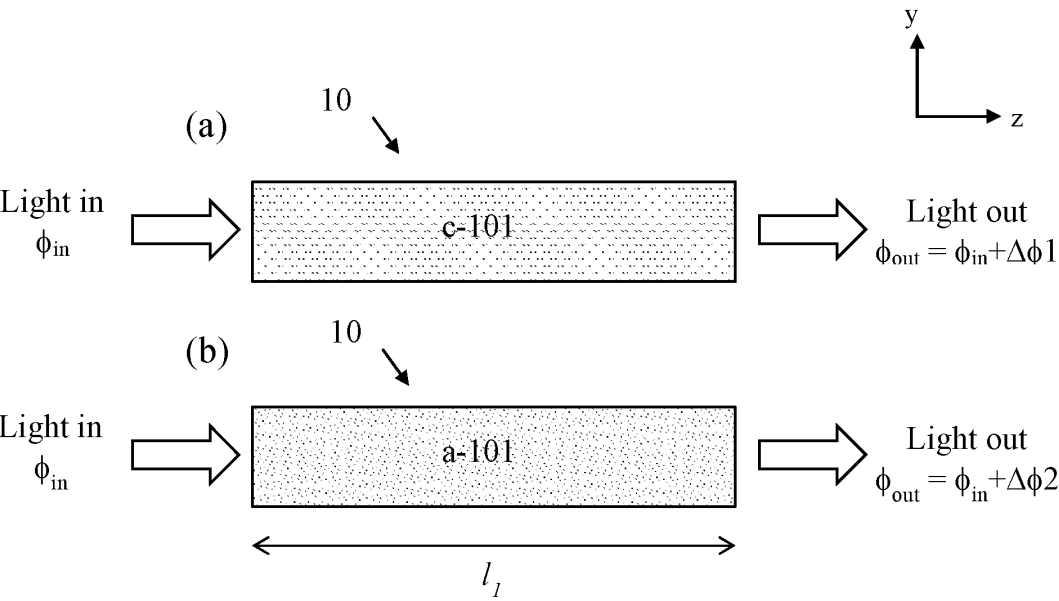


Figure 1

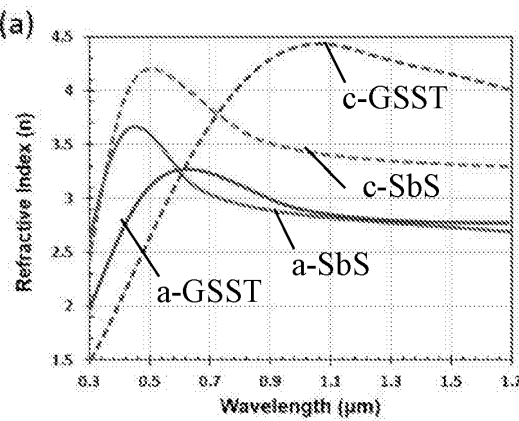


Figure 2(a)

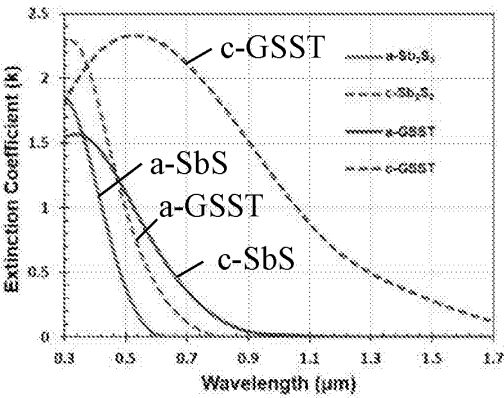


Figure 2(b)

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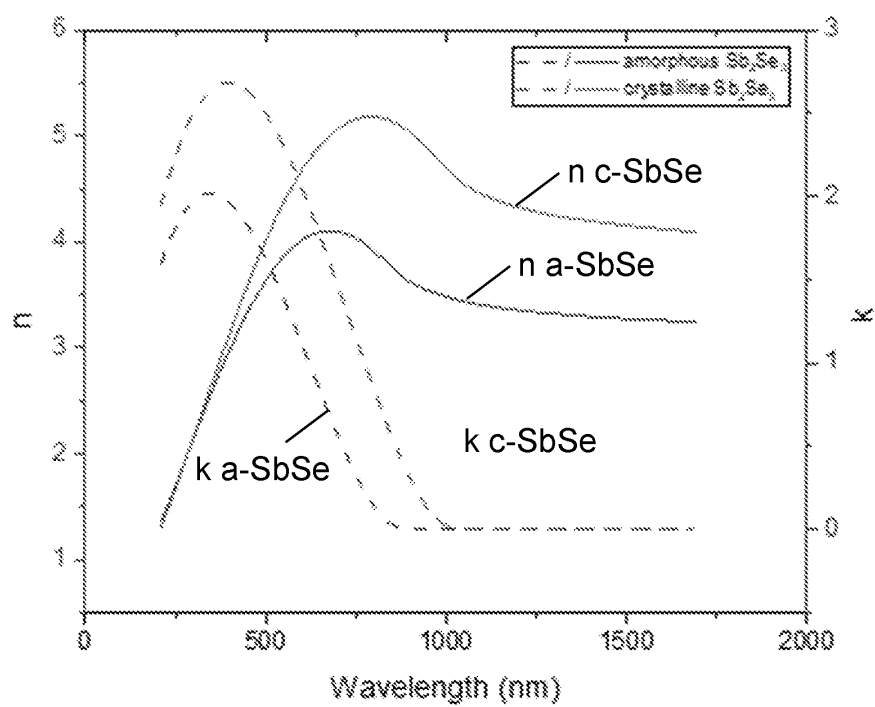
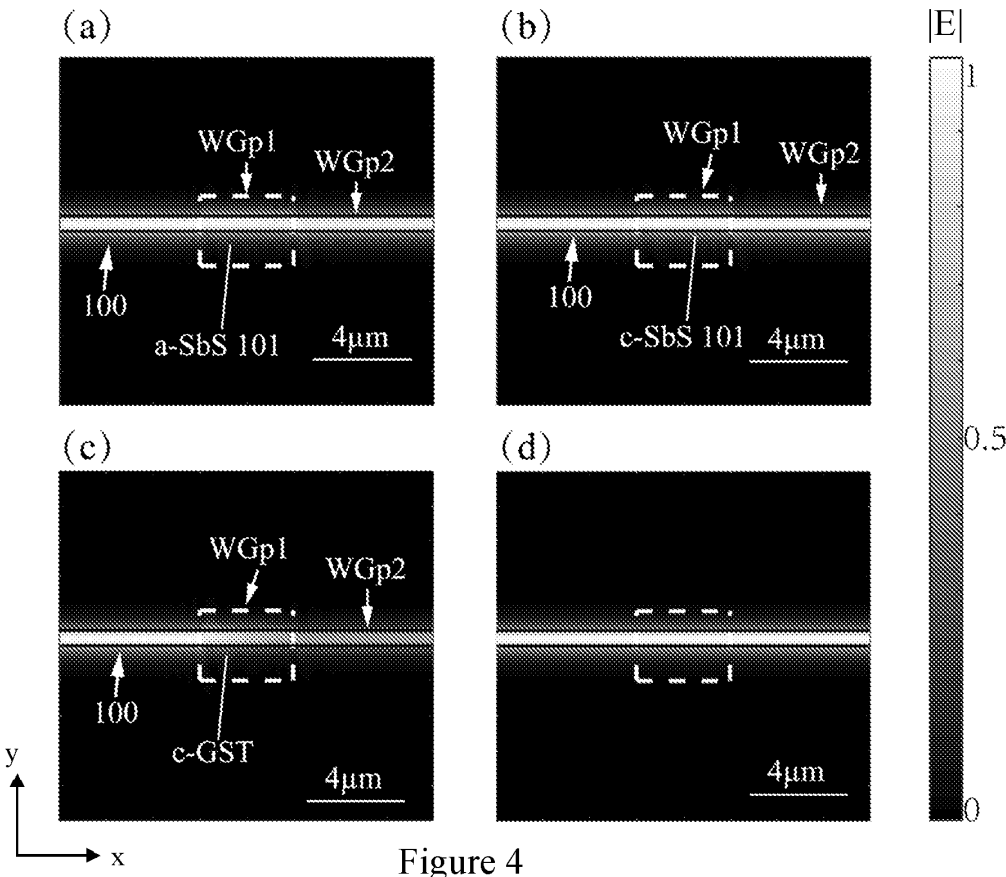
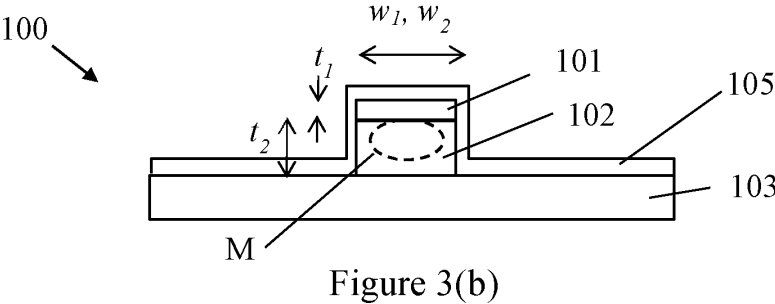
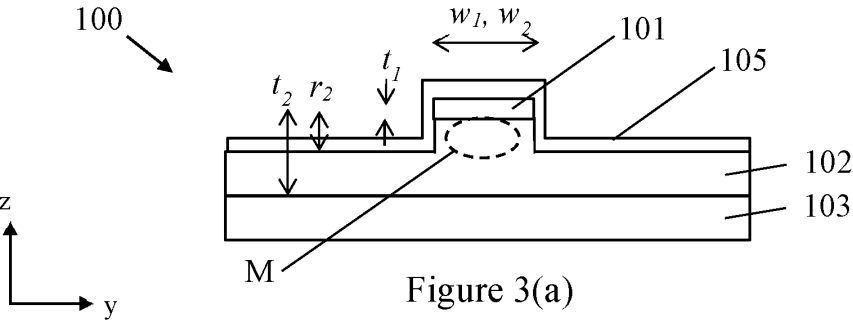
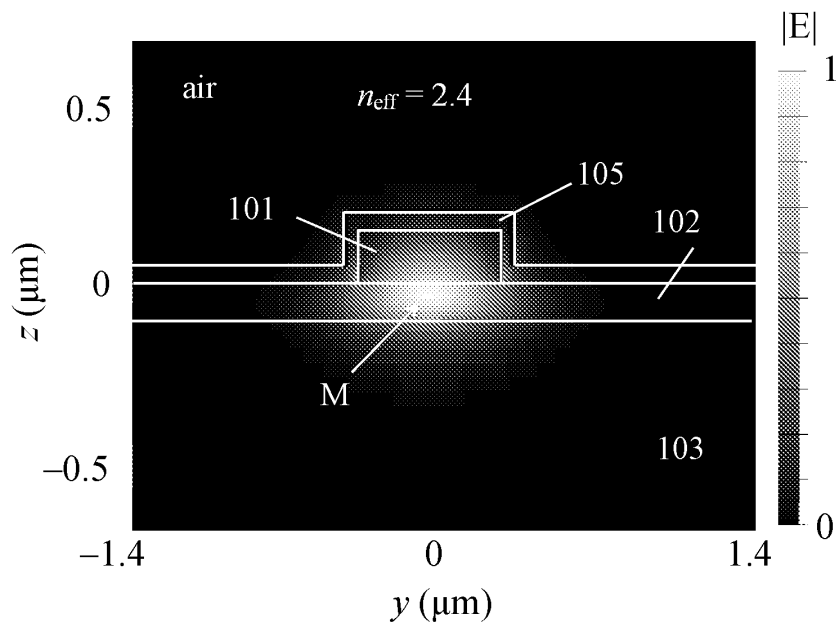
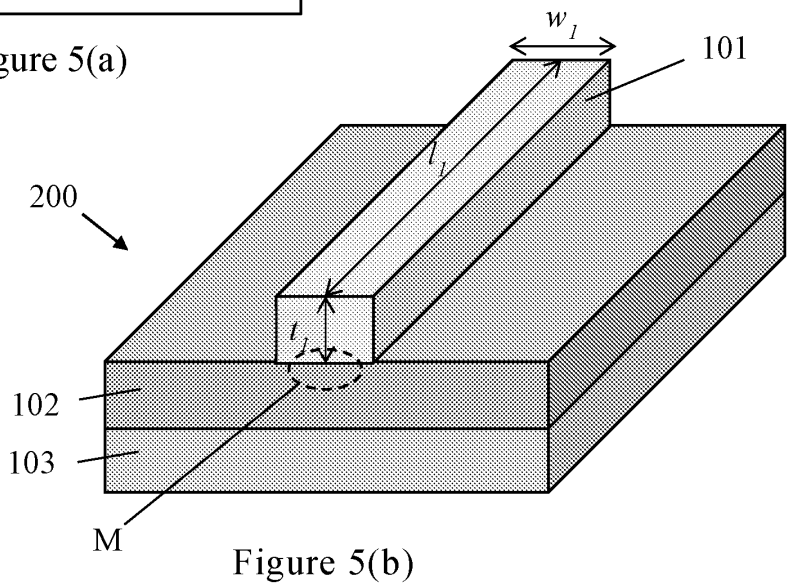
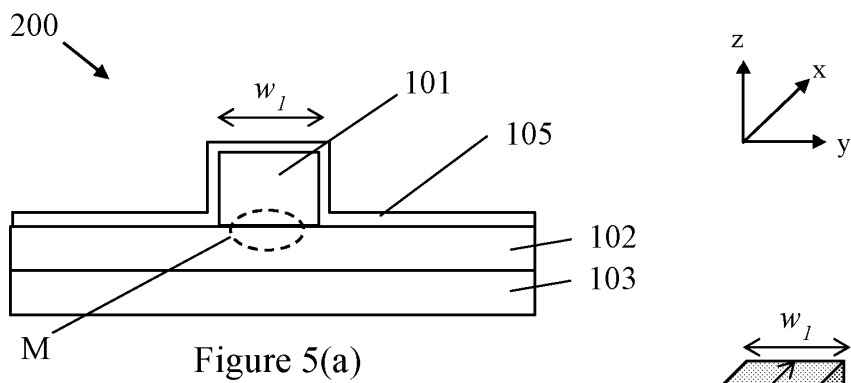


Figure 2(c)







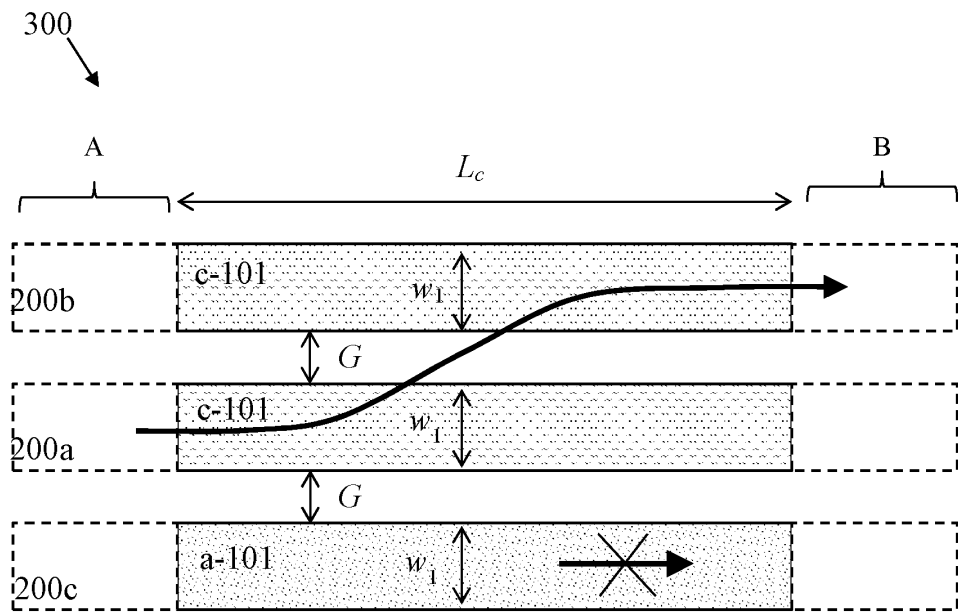


Figure 9(a)

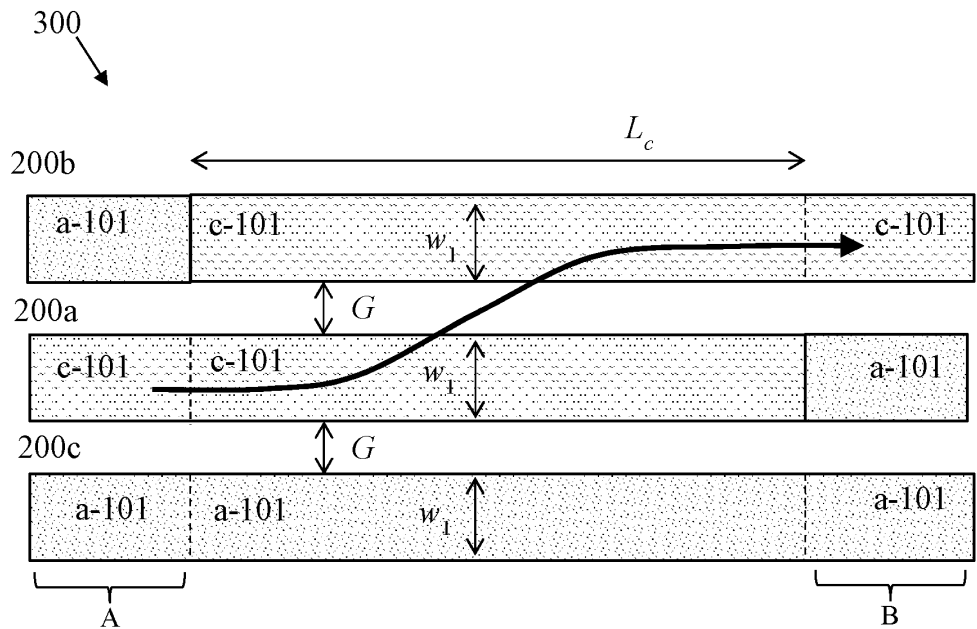


Figure 9(b)

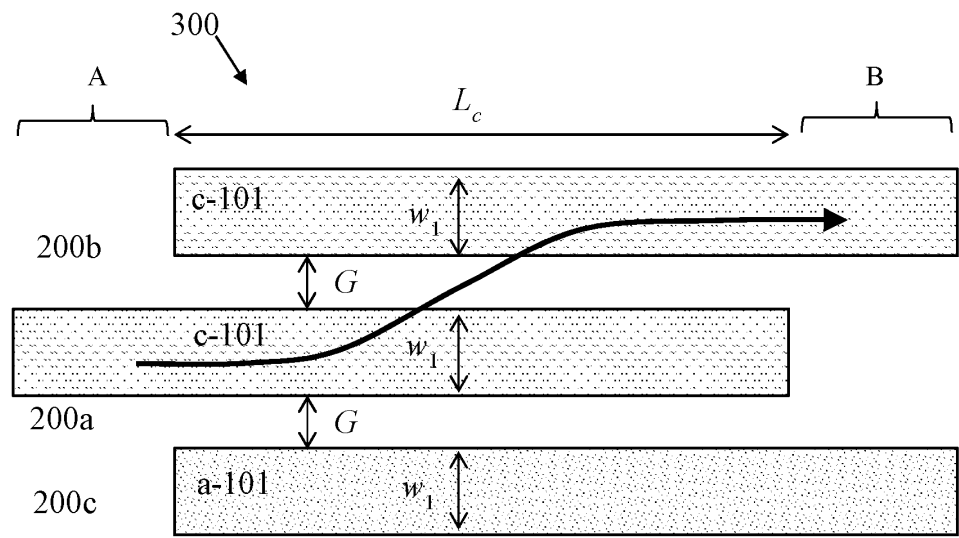


Figure 9(c)

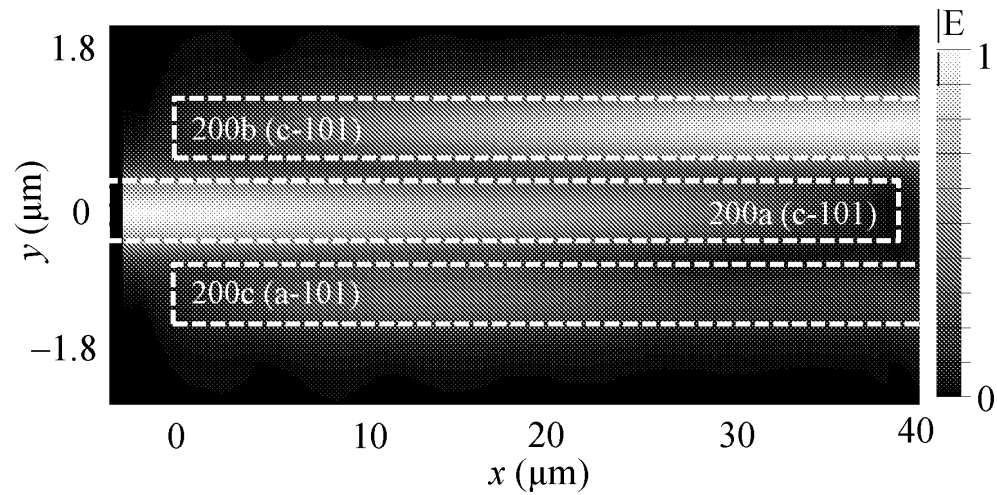


Figure 10(a)

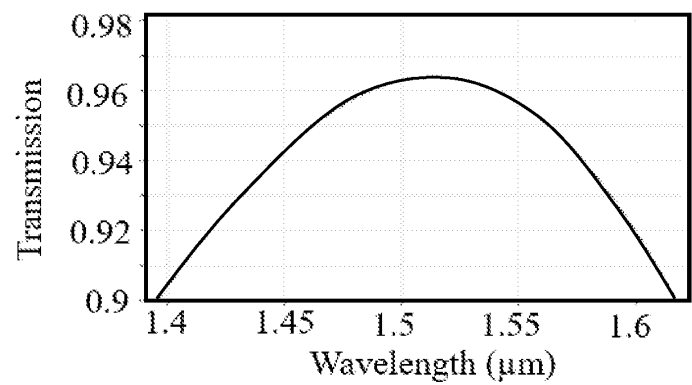


Figure 10(b)

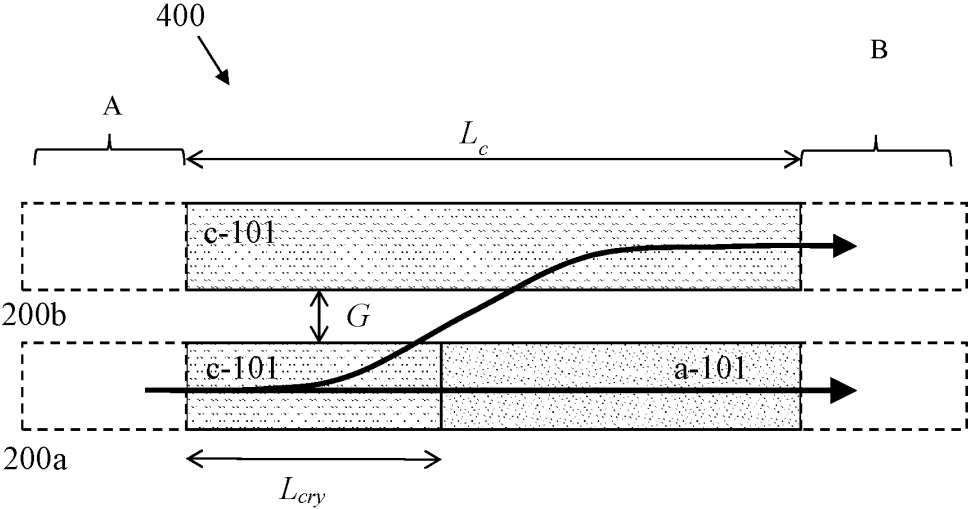


Figure 11

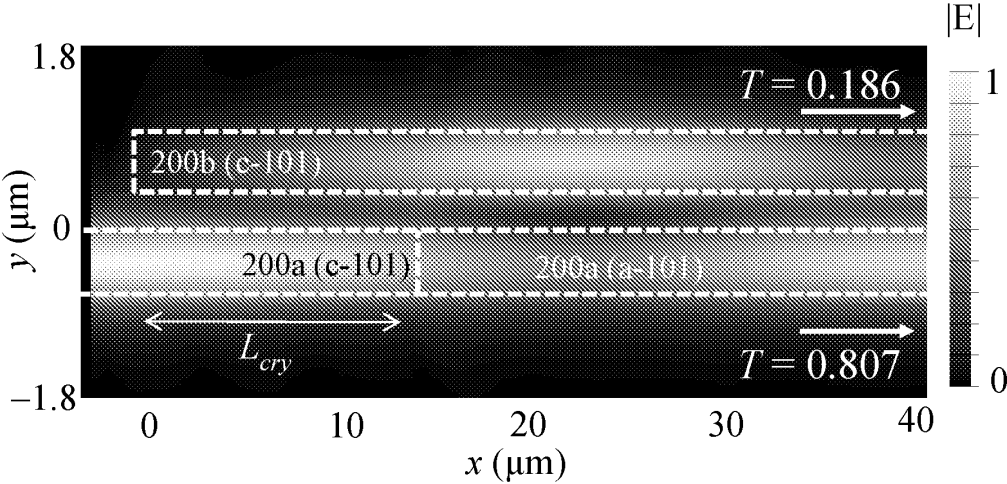


Figure 12(a)

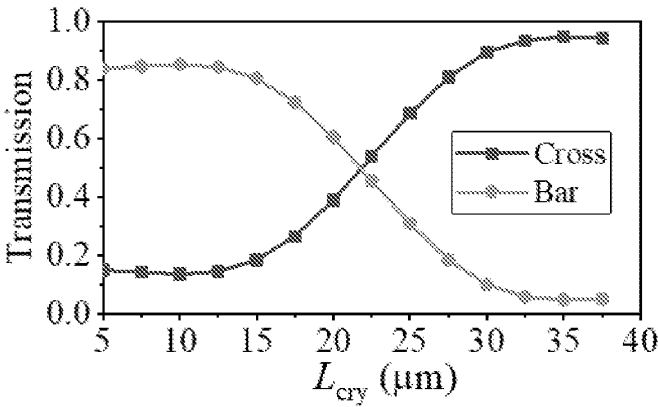


Figure 12(b)

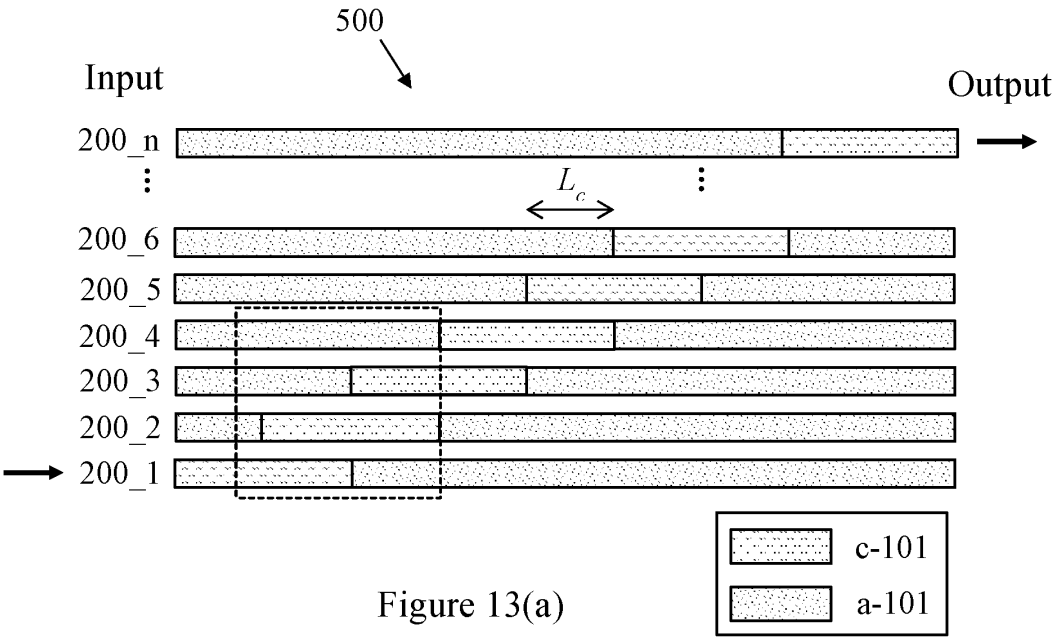


Figure 13(a)

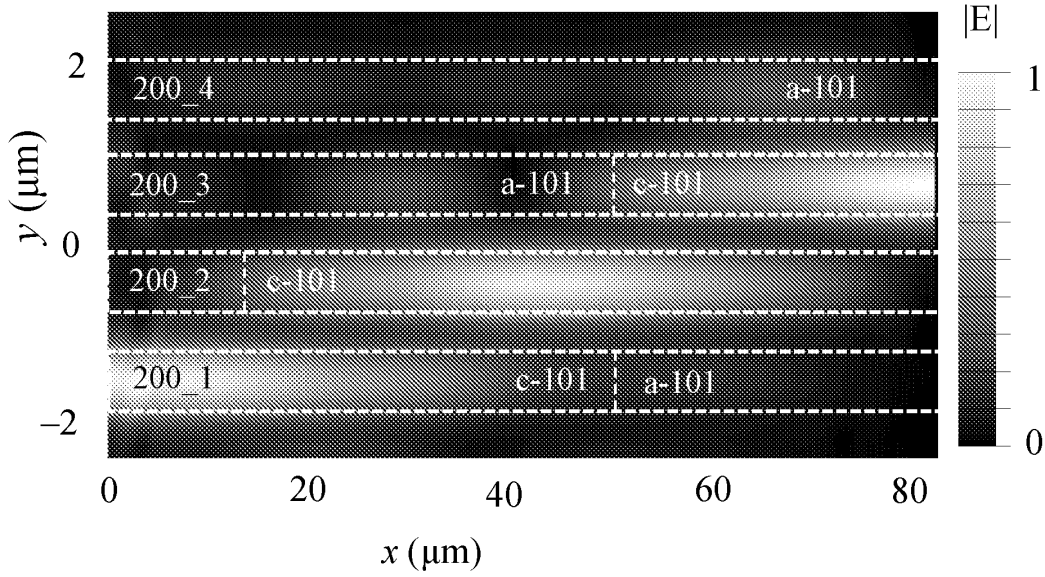


Figure 13(b)

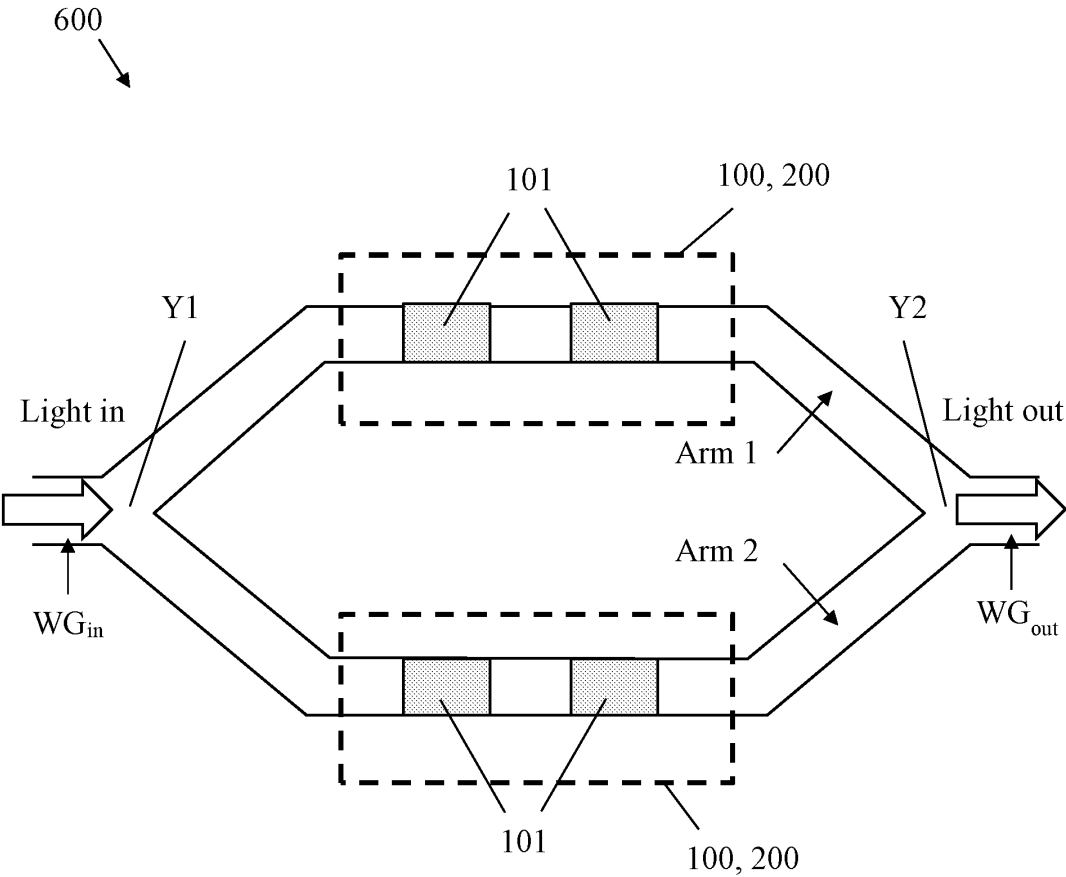


Figure 14

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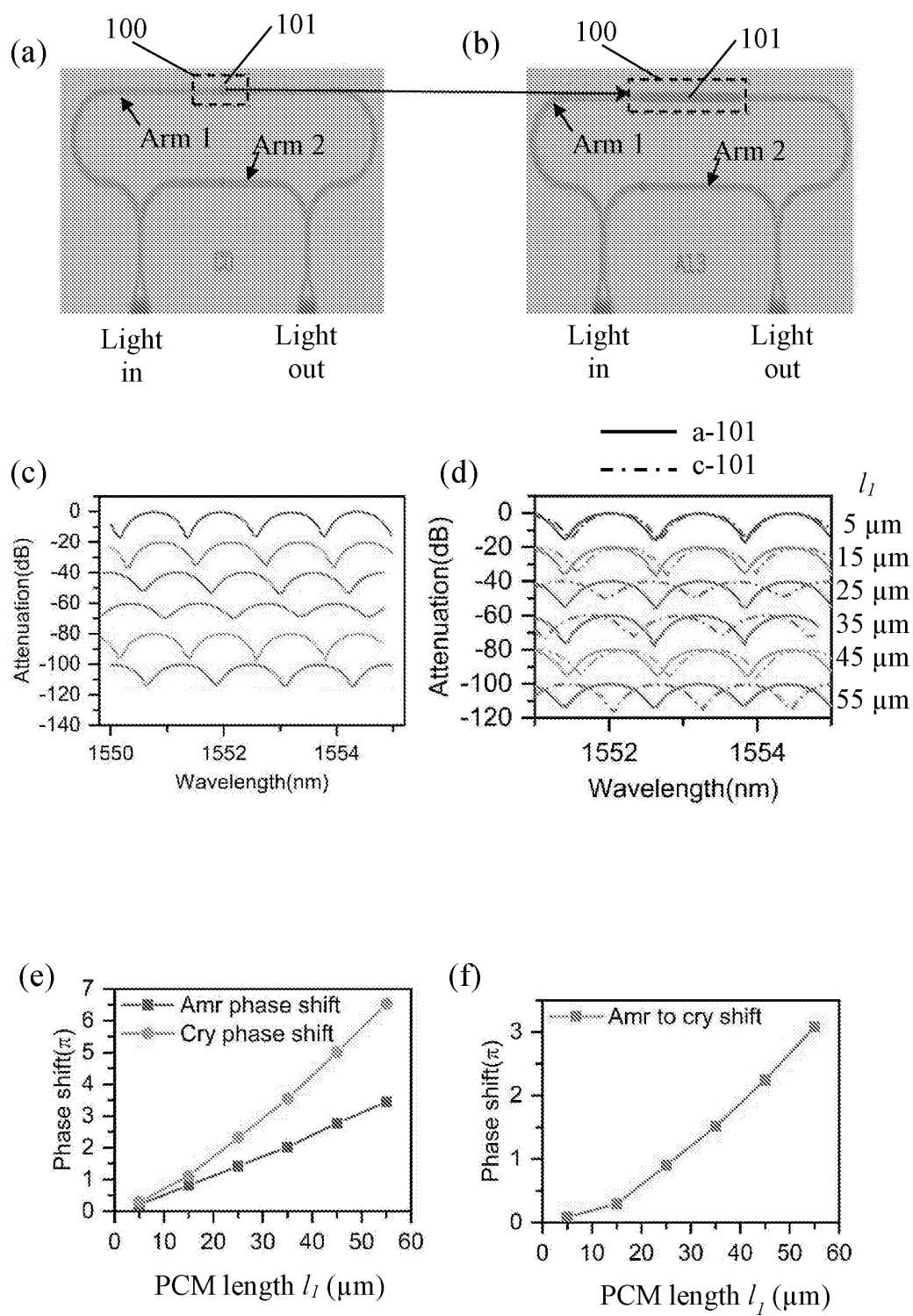


Figure 15

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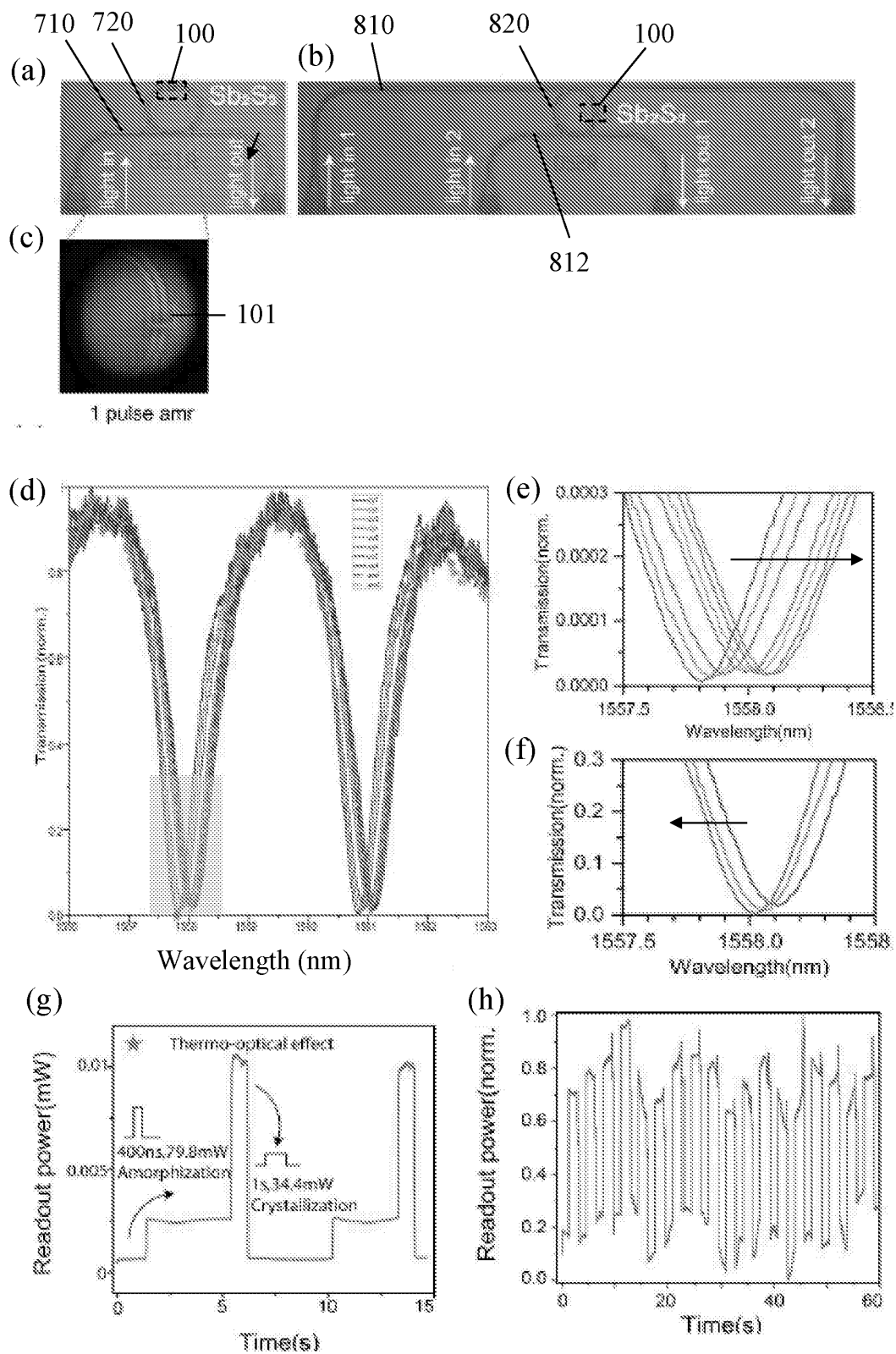


Figure 16

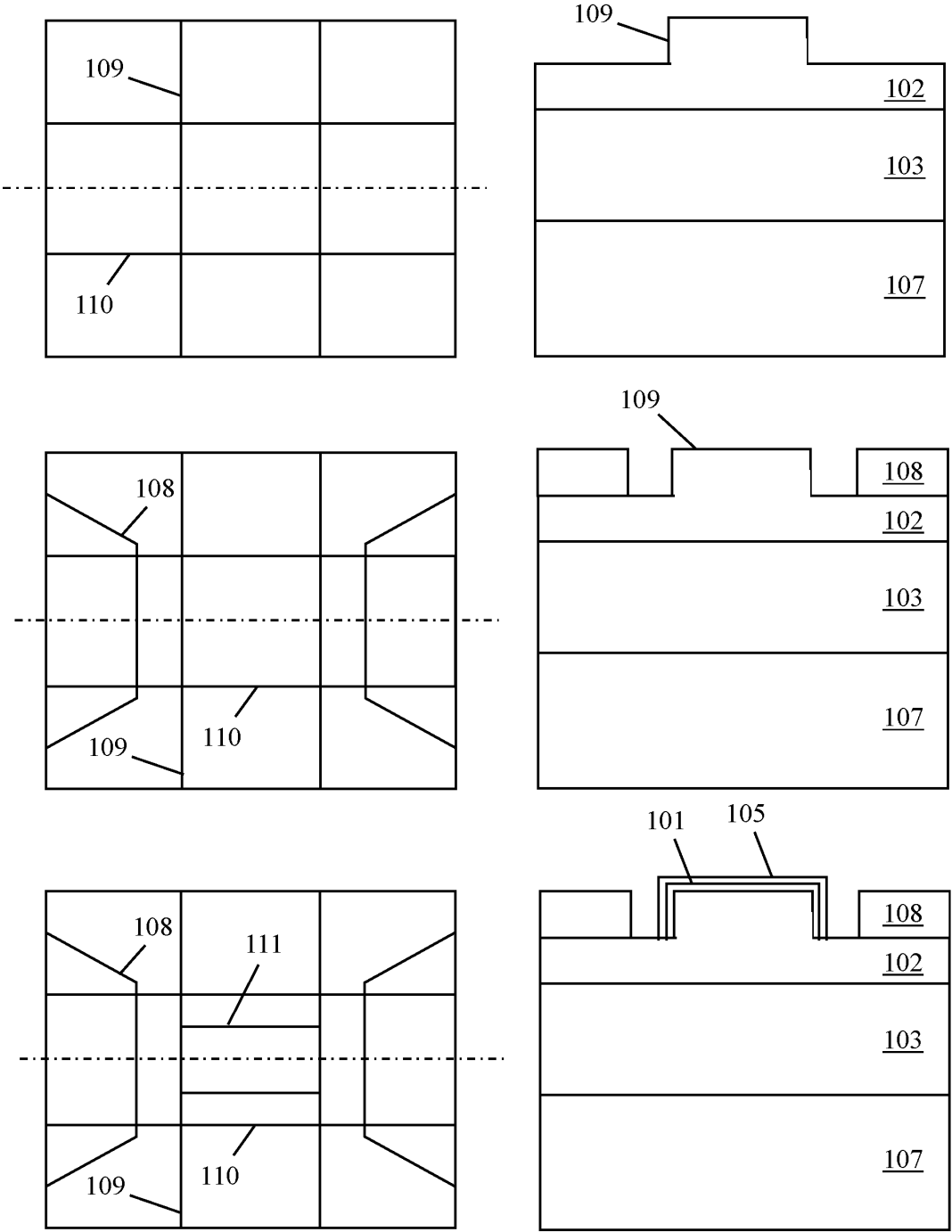


Figure 17

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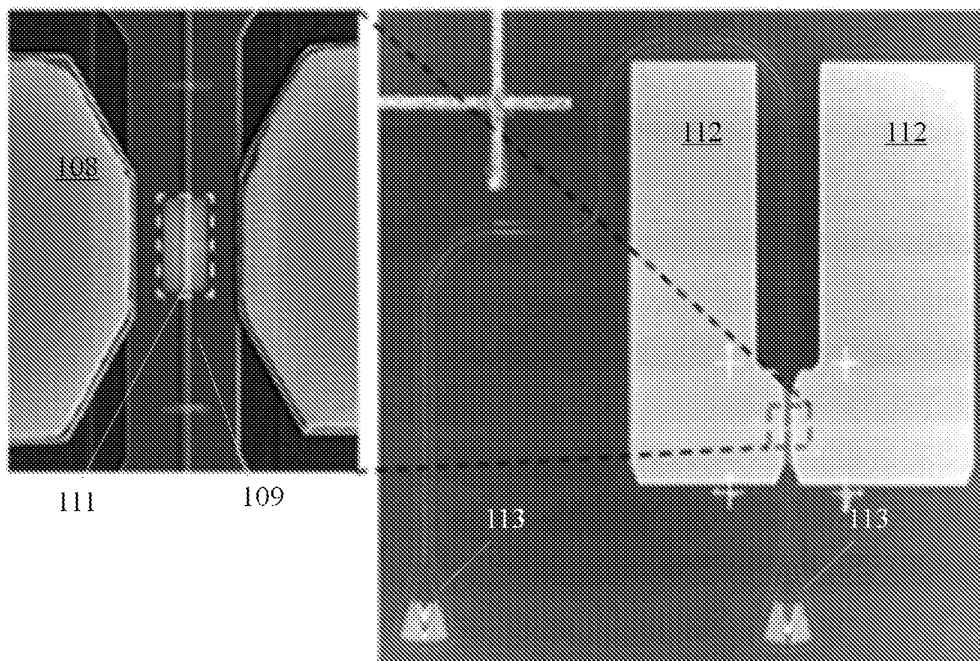


Figure 18

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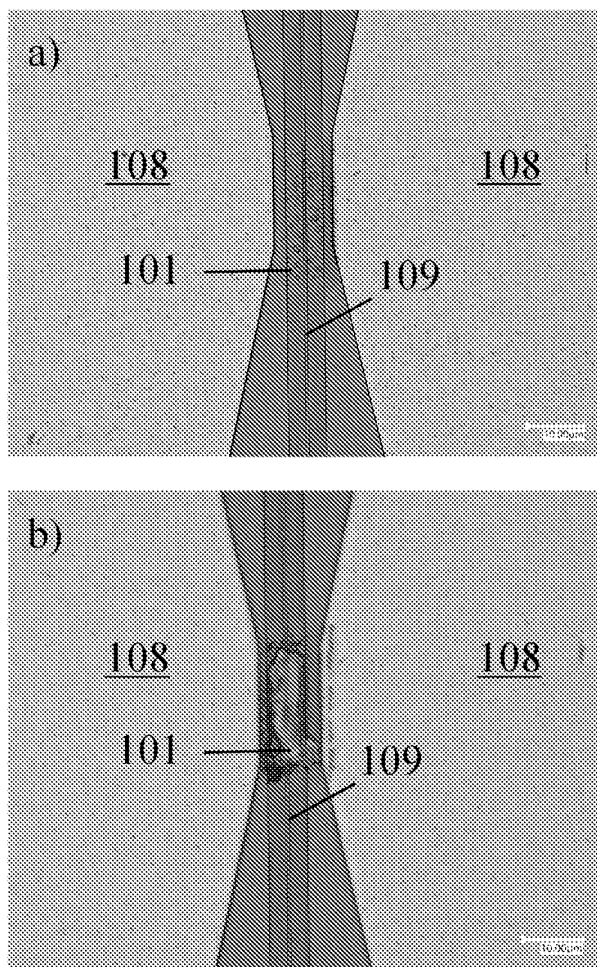


Figure 19

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Measurement in a single device

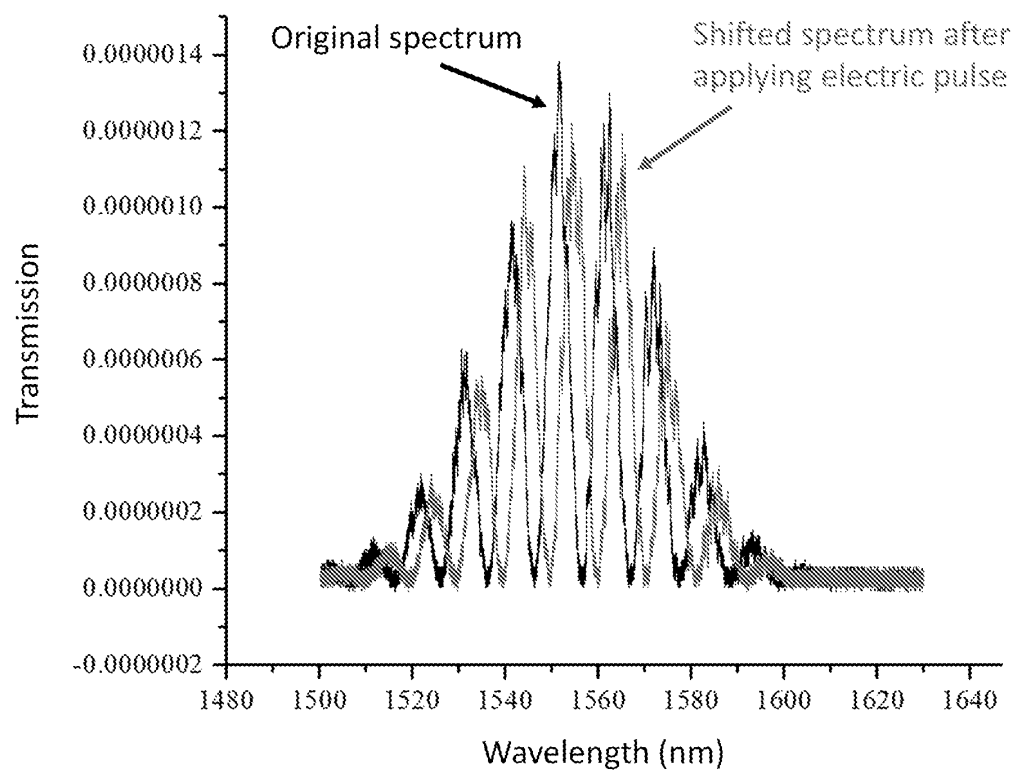


Figure 20